


<b>PCN Number:</b>	20211210001.1		<b>PCN Date:</b>	December 13, 2021																			
<b>Title:</b>	Qualification of additional Fab site (UMC-F12) and additional Assembly site (CDAT) for select LBC9 devices																						
<b>Customer Contact:</b>	<a href="#">PCN Manager</a>		<b>Dept:</b>	Quality Services																			
<b>Proposed 1<sup>st</sup> Ship Date:</b>	Mar 13, 2022		<b>Estimated Sample Availability:</b>	Date provided at sample request.																			
<b>Change Type:</b>																							
<input checked="" type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Assembly Process	<input checked="" type="checkbox"/>	Assembly Materials																		
<input type="checkbox"/>	Design	<input type="checkbox"/>	Electrical Specification	<input type="checkbox"/>	Mechanical Specification																		
<input type="checkbox"/>	Test Site	<input type="checkbox"/>	Packing/Shipping/Labeling	<input type="checkbox"/>	Test Process																		
<input type="checkbox"/>	Wafer Bump Site	<input type="checkbox"/>	Wafer Bump Material	<input type="checkbox"/>	Wafer Bump Process																		
<input checked="" type="checkbox"/>	Wafer Fab Site	<input type="checkbox"/>	Wafer Fab Materials	<input type="checkbox"/>	Wafer Fab Process																		
	<input type="checkbox"/>		Part number change																				
<b>PCN Details</b>																							
<b>Description of Change:</b>																							
Texas Instruments is pleased to announce the qualification of an additional fab (UMC-F12) and assembly site (CDAT) for the selected devices listed in the "Product Affected" section.																							
<table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th colspan="3">Current Fab Site</th> <th colspan="3">New Fab Site</th> </tr> <tr> <th>Current Fab Site</th> <th>Process</th> <th>Wafer Diameter</th> <th>New Fab Site</th> <th>Process</th> <th>Wafer Diameter</th> </tr> </thead> <tbody> <tr> <td>RFAB</td> <td>LBC9</td> <td>300 mm</td> <td>UMC-F12</td> <td>LBC9</td> <td>300 mm</td> </tr> </tbody> </table>						Current Fab Site			New Fab Site			Current Fab Site	Process	Wafer Diameter	New Fab Site	Process	Wafer Diameter	RFAB	LBC9	300 mm	UMC-F12	LBC9	300 mm
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Current Fab Site	Process	Wafer Diameter	New Fab Site	Process	Wafer Diameter																		
RFAB	LBC9	300 mm	UMC-F12	LBC9	300 mm																		
For the devices in in the group 1 device list below, construction differences are as follows:																							
<table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th></th> <th>TI CLARK</th> <th>CDAT</th> </tr> </thead> <tbody> <tr> <td>Mold Compound</td> <td>4222790</td> <td>4223495</td> </tr> </tbody> </table>							TI CLARK	CDAT	Mold Compound	4222790	4223495												
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Qual details are provided in the Qual Data Section.																							
<b>Reason for Change:</b>																							
Continuity of supply																							
<b>Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):</b>																							
None																							
<b>Impact on Environmental Ratings:</b>																							
Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.																							
<table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th>RoHS</th> <th>REACH</th> <th>Green Status</th> <th>IEC 62474</th> </tr> </thead> <tbody> <tr> <td><input checked="" type="checkbox"/> No Change</td> <td><input checked="" type="checkbox"/> No Change</td> <td><input checked="" type="checkbox"/> No Change</td> <td><input checked="" type="checkbox"/> No Change</td> </tr> </tbody> </table>						RoHS	REACH	Green Status	IEC 62474	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change										
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<b>Changes to product identification resulting from this PCN:</b>																							
<b>Fab Site Information:</b>																							
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<b>CDAT</b>	<b>CDA</b>	<b>CHN</b>	<b>Chengdu</b>																				

Sample product shipping label (not actual product label)


  
**TEXAS INSTRUMENTS**
  
 MADE IN: Malaysia
   
 2DC: 20:
   

MSL 2 /260C/1 YEAR	SEAL DT
MSL 1 /235C/UNLIM	03/29/04

  
 OPT:
   
 ITEM: 39
   
**LBL: 5A (L)T0:1750**



(1P) SN74LS07NSR
   
 (Q) 2000 (D) 0336
   
 (31T) LOT: 3959047MLA
   
 (4W) TKY(1T) 7523483SI2
   
 (P)
   
 (2P) REV: (V) 0033317
   
 (20L) CSO: SHE (21L) CCO: USA
   
 (22L) ASO: MLA (23L) ACO: MYS

**Product Affected:**

**Group 1 - Adding UMC-F12 Fab Site, CDAT Assembly Site and BOM updates:**

TPS62824DMQR	TPS6282533DMQR
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**Group 2 - Adding UMC-F12 Fab Site only:**

SN62825DMQR	TPS6282518DMQR	TPS62825DMQR	TPS6282618DMQR
SN62826DMQR	TPS6282518DMQT	TPS62825DMQT	TPS6282618DMQT
SN62827DMQR	TPS62826DMQR	TPS62826DMQT	



TI Information  
Selective Disclosure

**Qualification Report**

Approve Date 06-December-2021

**Qualification Results**

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: SN62825DMQR	Qual Device: SN62827DMQR	QBS Process Device: TPS51486RJR	QBS Package Device: SN62825DMQR
AC	Autoclave, 121C, 2 atm	96 Hours	-	-	3/231/0	-
ED	Electrical Characterization	Per Datasheet Parameters	Pass	Pass	Pass	Pass
ELFR	Early Life Failure Rate, 125C	48 Hours	-	-	3/2400/0	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	3/231/0	3/231/0
HBM	ESD - HBM	2000 V	1/3/0	-	3/9/0	-
CDM	ESD - CDM	500 V	1/3/0	-	3/9/0	-
HTOL	Life Test, 125C	1000 Hours	1/77/0	-	3/231/0	-
HTSL	High Temp. Storage Bake, 170C	420 Hours	-	-	3/231/0	2/154/0
LU	Latch-up	(per JESD78)	1/6/0	-	3/18/0	-
TC	Temperature Cycle, -55/125C	700 Cycles	1/77/0	-	3/231/0	-
TC	Temperature Cycle, -65/150C	500 Cycles	-	-	-	3/231/0
UHASt	Unbiased HAST, 130C/85%RH	96 Hours	-	-	-	3/231/0

- Qual Device SN62825DMQR is qualified at LEVEL1-260C
- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

**Green/Pb-free Status:**

Qualified Pb-Free(SMT) and Green

TI Qualification ID: 20200520-134332

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

<b>Location</b>	<b>E-Mail</b>
USA	<a href="mailto:PCNAmericasContact@list.ti.com">PCNAmericasContact@list.ti.com</a>
Europe	<a href="mailto:PCNEuropeContact@list.ti.com">PCNEuropeContact@list.ti.com</a>
Asia Pacific	<a href="mailto:PCNAsiaContact@list.ti.com">PCNAsiaContact@list.ti.com</a>
WW PCN Team	<a href="mailto:PCN_ww_admin_team@list.ti.com">PCN_ww_admin_team@list.ti.com</a>

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